

NVBLS0D7N04M8

MOSFET – Power, Single, N-Channel

40 V, 240 A, 0.75 mΩ

Features

- Typical $R_{DS(on)}$ = 0.59 mΩ at $V_{GS} = 10$ V, $I_D = 80$ A
- Typical $Q_{g(tot)}$ = 144 nC at $V_{GS} = 10$ V, $I_D = 80$ A
- UIS Capability
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS $T_J = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Ratings	Units
Drain-to-Source Voltage	V_{DSS}	40	V
Gate-to-Source Voltage	V_{GS}	± 20	V
Drain Current – Continuous ($V_{GS} = 10$) (Note 1)	I_D	240	A
Pulsed Drain Current $T_C = 25^\circ\text{C}$		See Figure 4	
Single Pulse Avalanche Energy (Note 2)	E_{AS}	737	mJ
Power Dissipation	P_D	357	W
Derate Above 25°C		2.38	
Operating and Storage Temperature	T_J, T_{STG}	-55 to +175	$^\circ\text{C}$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.42	$^\circ\text{C/W}$
Maximum Thermal Resistance, Junction-to-Ambient (Note 3)	$R_{\theta JA}$	43	$^\circ\text{C/W}$

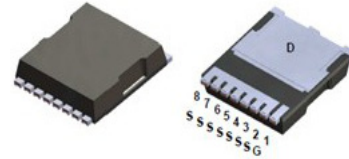
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Current is limited by bondwire configuration.
2. Starting $T_J = 25^\circ\text{C}$, $L = 0.36$ mH, $I_{AS} = 64$ A, $V_{DD} = 40$ V during inductor charging and $V_{DD} = 0$ V during time in avalanche.
3. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design, while $R_{\theta JA}$ is determined by the board design. The maximum rating presented here is based on mounting on a 1 in² pad of 2 oz copper.

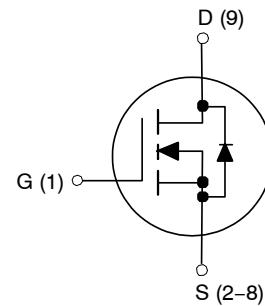


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**MO-299A
CASE 100CU**



ORDERING INFORMATION

Device	Package	Marking
NVBLS0D7N04M8TXG	MO-299A (Pb-Free)	0D7N04M8

NVBS0D7N04M8

Table 1. ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units	
OFF CHARACTERISTICS							
B_{VDSS}	Drain-to-Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{ V}$	40	-	-	V	
I_{DSS}	Drain-to-Source Leakage Current	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$	$T_J = 25^\circ\text{C}$	-	-	1	μA
			$T_J = 175^\circ\text{C}$ (Note 4)	-	-	1	mA
I_{GSS}	Gate-to-Source Leakage Current	$V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
ON CHARACTERISTICS							
$V_{GS(th)}$	Gate-to-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$	2.0	3.3	4.0	V	
$R_{DS(on)}$	Drain-to-Source On Resistance	$I_D = 80 \text{ A}, V_{GS} = 10 \text{ V}$	-	0.59	0.75	$\text{m}\Omega$	
DYNAMIC CHARACTERISTICS							
C_{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	12000	-	pF	
C_{oss}	Output Capacitance		-	3300	-	pF	
C_{rss}	Reverse Transfer Capacitance		-	440	-	pF	
R_g	Gate Resistance	$f = 1 \text{ MHz}$	-	3.3	-	Ω	
$Q_{g(ToT)}$	Total Gate Charge at 10 V	$V_{GS} = 0 \text{ to } 10 \text{ V}$	-	144	188	nC	
$Q_{g(th)}$	Threshold Gate Charge	$V_{GS} = 0 \text{ to } 2 \text{ V}$					
Q_{gs}	Gate-to-Source Gate Charge		-	66	-	nC	
Q_{gd}	Gate-to-Drain "Miller" Charge		-	16	-	nC	
SWITCHING CHARACTERISTICS							
t_{on}	Turn-On Time	$V_{DD} = 20 \text{ V}, I_D = 80 \text{ A}, V_{GS} = 10 \text{ V}, R_{GEN} = 6 \Omega$	-	-	162	ns	
$t_{d(on)}$	Turn-On Delay		-	42	-	ns	
t_r	Rise Time		-	73	-	ns	
$t_{d(off)}$	Turn-Off Delay		-	83	-	ns	
t_f	Fall Time		-	50	-	ns	
t_{off}	Turn-Off Time		-	-	279	ns	
DRAIN-SOURCE DIODE CHARACTERISTICS							
V_{SD}	Source-to-Drain Diode Voltage	$I_{SD} = 80 \text{ A}, V_{GS} = 0 \text{ V}$	-	-	1.25	V	
		$I_{SD} = 40 \text{ A}, V_{GS} = 0 \text{ V}$	-	-	1.2	V	
t_{rr}	Reverse-Recovery Time	$I_F = 80 \text{ A}, dI_{SD}/dt = 100 \text{ A}/\mu\text{s}, V_{DD} = 32 \text{ V}$	-	111	129	ns	
Q_{rr}	Reverse-Recovery Charge		-	178	214	nC	

4. The maximum value is specified by design at $T_J = 175^\circ\text{C}$. Product is not tested to this condition in production. Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Typical Characteristics

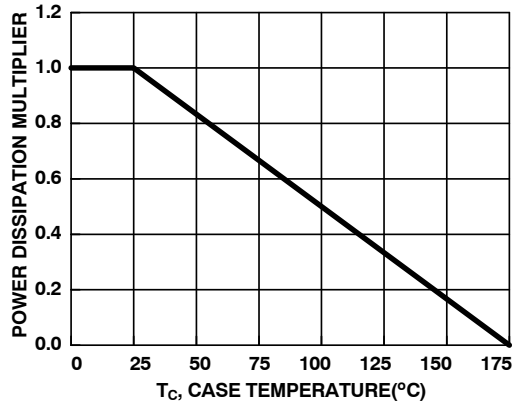


Figure 1. Normalized Power Dissipation vs. Case Temperature

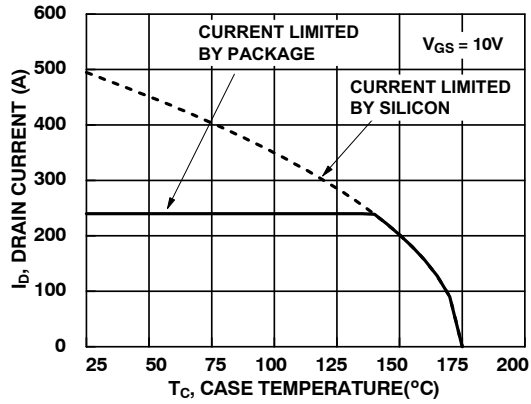


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

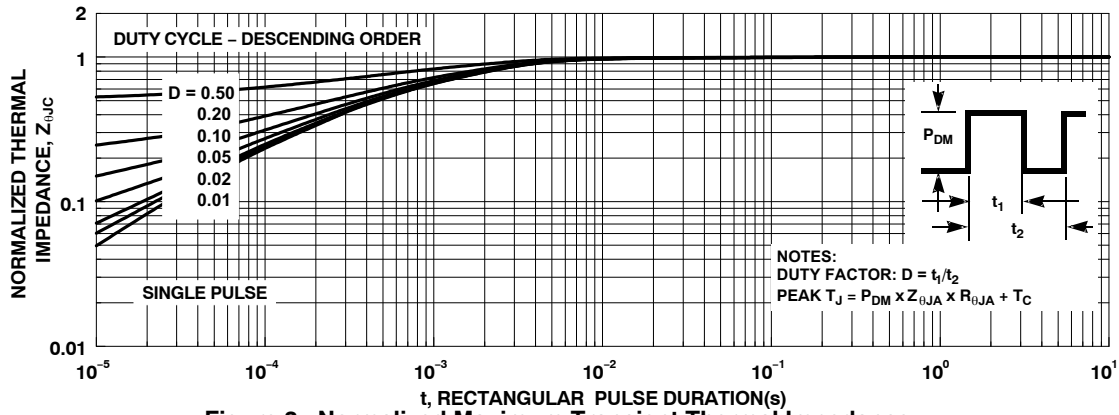


Figure 3. Normalized Maximum Transient Thermal Impedance

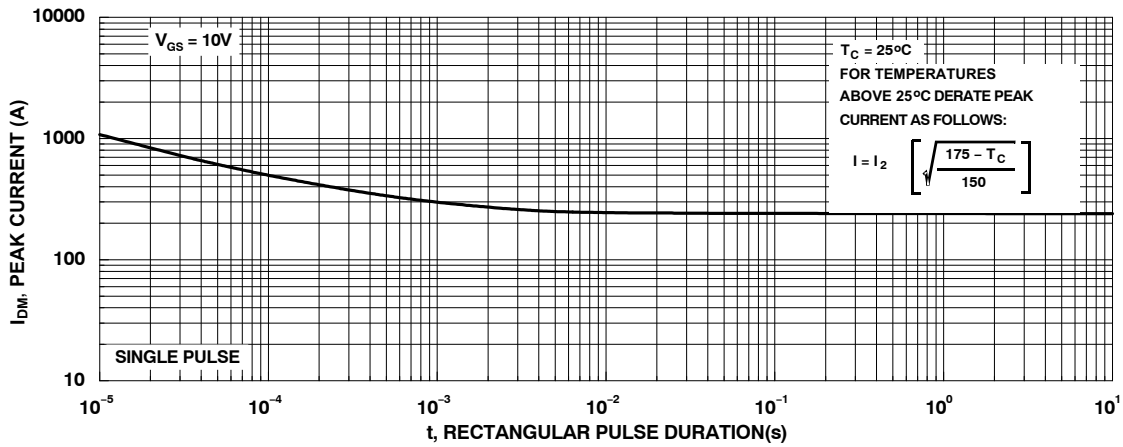


Figure 4. Peak Current Capability

Typical Characteristics

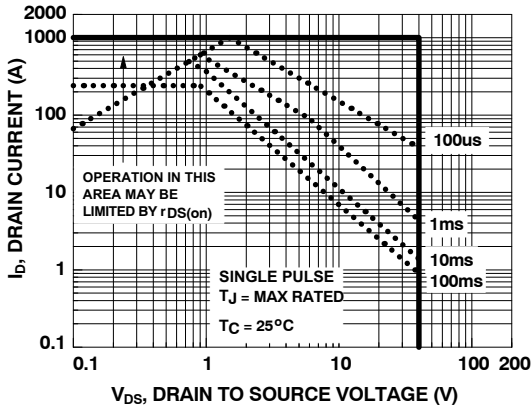
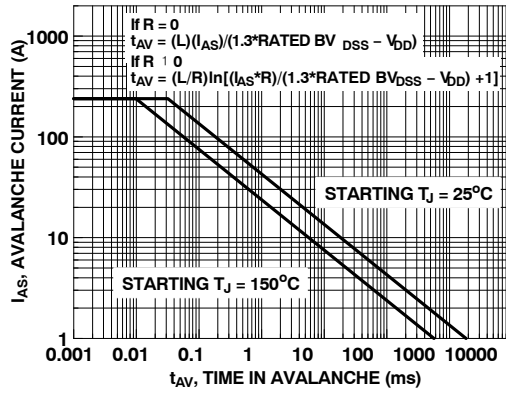


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to Fairchild Application Notes AN7514 and AN7515

Figure 6. Unclamped Inductive Switching Capability

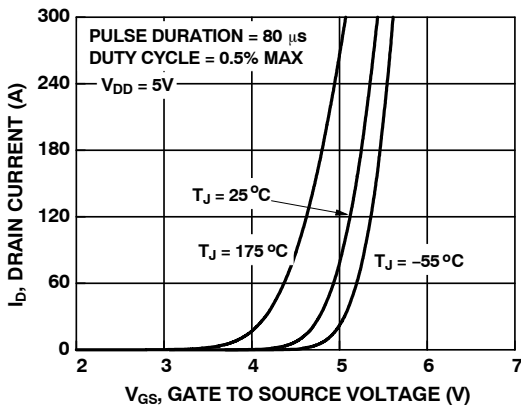


Figure 7. Transfer Characteristics

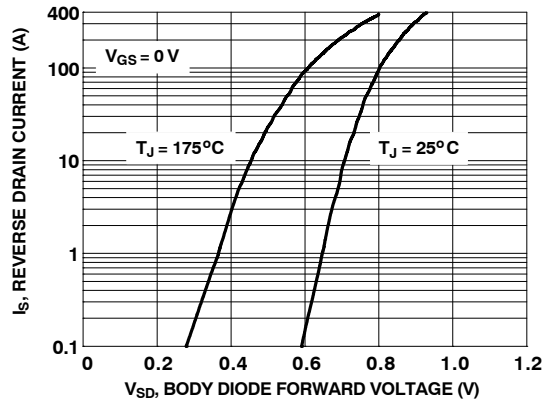


Figure 8. Forward Diode Characteristics

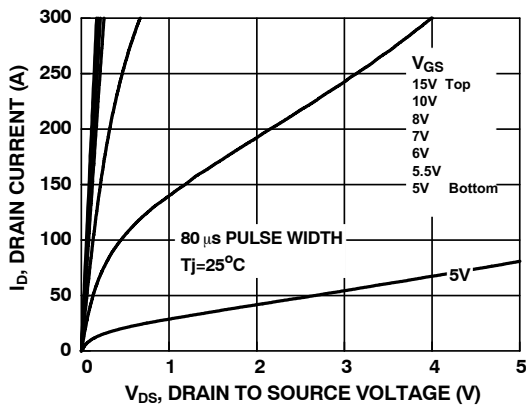


Figure 9. Saturation Characteristics

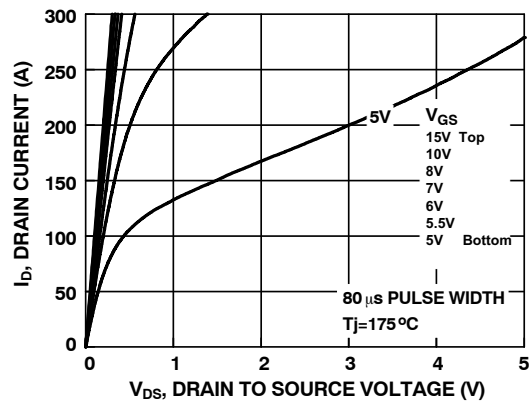


Figure 10. Saturation Characteristics

Typical Characteristics

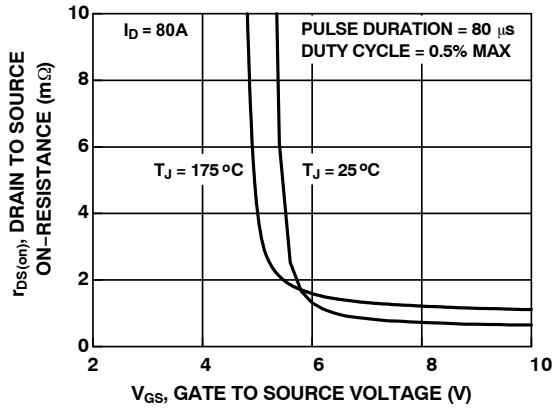


Figure 11. $R_{DS(on)}$ vs. Gate Voltage

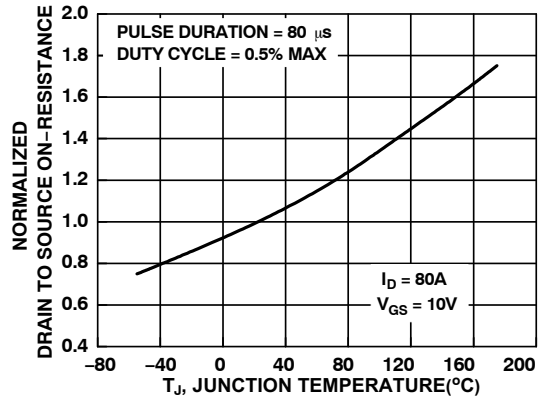


Figure 12. Normalized $R_{DS(on)}$ vs. Junction Temperature

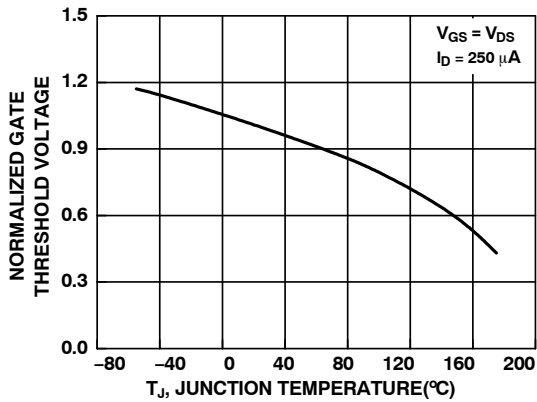


Figure 13. Normalized Gate Threshold Voltage vs. Temperature

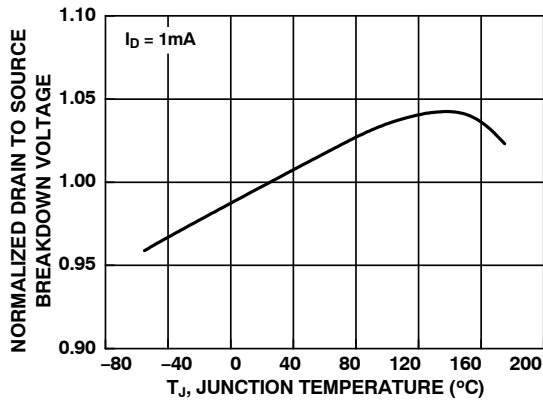


Figure 14. Normalized Drain to Source Breakdown Voltage vs. Junction Temperature

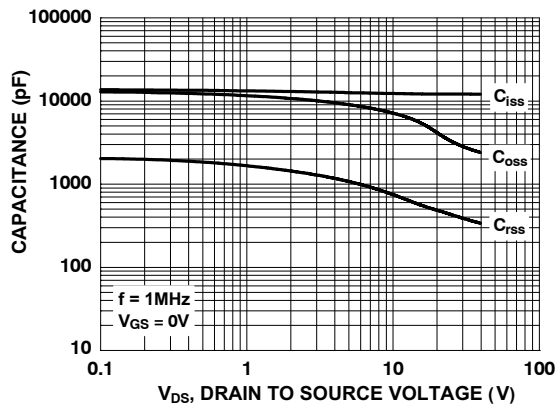


Figure 15. Capacitance vs. Drain to Source Voltage

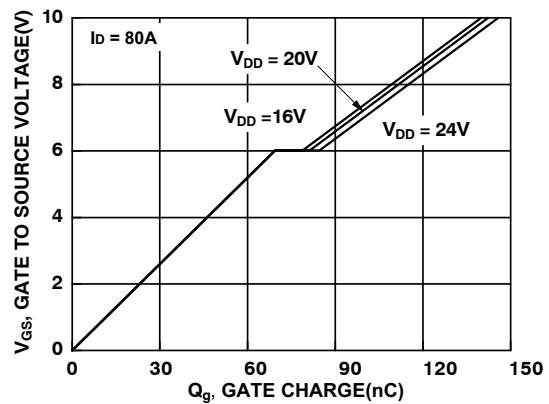


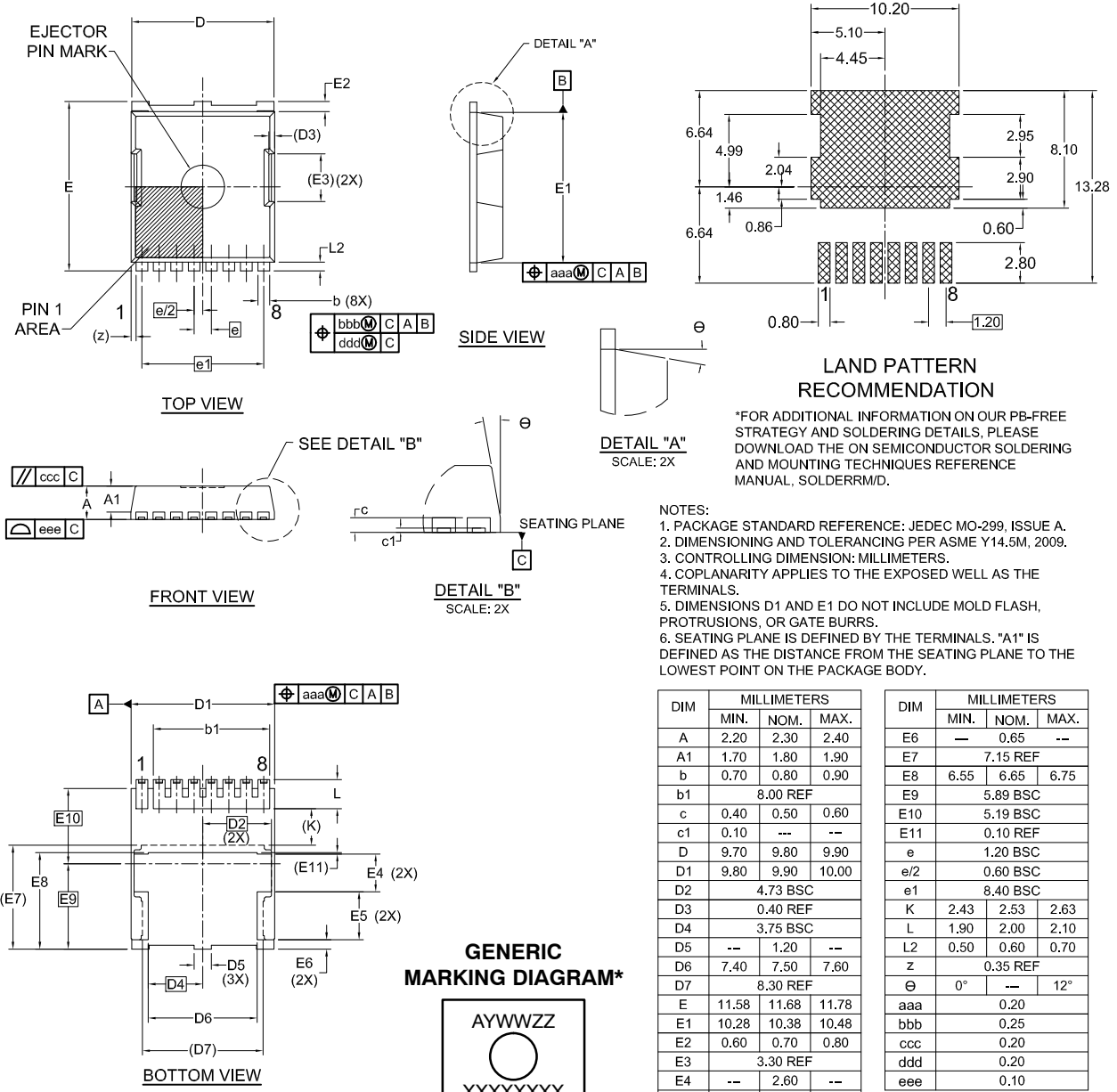
Figure 16. Gate Charge vs. Gate to Source Voltage

MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS



H-PSOF8L 11.68x9.80 CASE 100CU ISSUE B

DATE 20 MAY 2022



*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

- NOTES:
1. PACKAGE STANDARD REFERENCE: JEDEC MO-299, ISSUE A.
 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
 3. CONTROLLING DIMENSION: MILLIMETERS.
 4. COPLANARITY APPLIES TO THE EXPOSED WELL AS THE TERMINALS.
 5. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
 6. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	2.20	2.30	2.40
A1	1.70	1.80	1.90
b	0.70	0.80	0.90
b1	8.00 REF		
c	0.40	0.50	0.60
c1	0.10	---	---
D	9.70	9.80	9.90
D1	9.80	9.90	10.00
D2	4.73 BSC		
D3	0.40 REF		
D4	3.75 BSC		
D5	---	1.20	---
D6	7.40	7.50	7.60
D7	8.30 REF		
E	11.58	11.68	11.78
E1	10.28	10.38	10.48
E2	0.60	0.70	0.80
E3	3.30 REF		
E4	---	2.60	---
E5	---	3.30	---

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
E6	---	0.65	---
E7	7.15 REF		
E8	6.55	6.65	6.75
E9	5.89 BSC		
E10	5.19 BSC		
E11	0.10 REF		
e	1.20 BSC		
e/2	0.60 BSC		
e1	8.40 BSC		
K	2.43	2.53	2.63
L	1.90	2.00	2.10
L2	0.50	0.60	0.70
z	0.35 REF		
θ	0°	---	12°
aaa	0.20		
bbb	0.25		
ccc	0.20		
ddd	0.20		
eee	0.10		

A = Assembly Location
 Y = Year
 WW = Work Week
 ZZ = Assembly Lot Code
 XXXX = Specific Device Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "a", may or may not be present. Some products may not follow the Generic Marking.

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